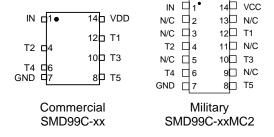
5-TAP, HCMOS-INTERFACED FIXED DELAY LINE (SERIES SMD99C)



FEATURES PACKAGES

- · Five equally spaced outputs
- Designed for surface mounting
- Low profile (0.175 maximum height)
- Input & outputs fully CMOS interfaced & buffered
- 10 T²L fan-out capability



FUNCTIONAL DESCRIPTION

The SMD99C-series device is a 5-tap digitally buffered delay line. The signal input (IN) is reproduced at the outputs (T1-T5), shifted in time by an amount determined by the device dash number (See Table). The total delay of the line is measured from IN to T5. The nominal tap-to-tap delay increment is given by one-fifth of the total delay.

PIN DESCRIPTIONS

IN Signal Input T1-T5 Tap Outputs VDD +5 Volts GND Ground

SERIES SPECIFICATIONS

Minimum input pulse width: 40% of total delay

Output rise time: 8ns typical
Supply voltage: 5VDC ± 5%
Supply current: I_{CCL} = 40µa typical

I_{CCH} = 10ma typical

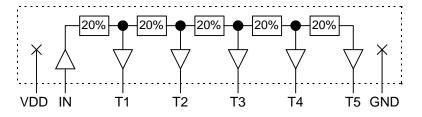
• Operating temperature: 0° to 70° C

• Temp. coefficient of total delay: 300 PPM/°C

DASH NUMBER SPECIFICATIONS

Part	Total	Delay Per
Number	Delay (ns)	Tap (ns)
SMD99C-5050	50 ± 2.5	10.0 ± 3.0
SMD99C-5060	60 ± 3.0	12.0 ± 3.0
SMD99C-5075	75 ± 4.0	15.0 ± 3.0
SMD99C-5100	100 ± 5.0	20.0 ± 3.0
SMD99C-5125	125 ± 6.5	25.0 ± 3.0
SMD99C-5150	150 ± 7.5	30.0 ± 3.0
SMD99C-5175	175 ± 8.0	35.0 ± 4.0
SMD99C-5200	200 ± 10.0	40.0 ± 4.0
SMD99C-5250	250 ± 12.5	50.0 ± 5.0

NOTE: Any dash number between 5004 and 5250 not shown is also available.



DDU8C Functional diagram

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APPLICATION NOTES

HIGH FREQUENCY RESPONSE

The SMD99C tolerances are guaranteed for input pulse widths and periods greater than those specified in the test conditions. Although the device will function properly for pulse widths as small as 40% of the total delay and periods as small as 80% of the total delay (for a symmetric input), the delays may deviate from their values at low frequency. However, for a given input condition, the deviation will be repeatable from pulse to pulse. Contact technical support at Data

Delay Devices if your application requires device testing at a specific input condition.

POWER SUPPLY BYPASSING

The SMD99C relies on a stable power supply to produce repeatable delays within the stated tolerances. A 0.1uf capacitor from VDD to GND, located as close as possible to the VDD pin, is recommended. A wide VDD trace and a clean ground plane should be used.

DEVICE SPECIFICATIONS

TABLE 1: ABSOLUTE MAXIMUM RATINGS

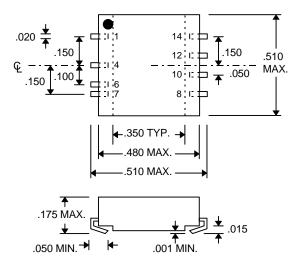
PARAMETER	SYMBOL	MIN	MAX	UNITS	NOTES
DC Supply Voltage	V_{DD}	-0.3	7.0	V	
Input Pin Voltage	V_{IN}	-0.3	V _{DD} +0.3	V	
Storage Temperature	T_{STRG}	-55	150	С	
Lead Temperature	T_{LEAD}		300	С	10 sec

TABLE 2: DC ELECTRICAL CHARACTERISTICS

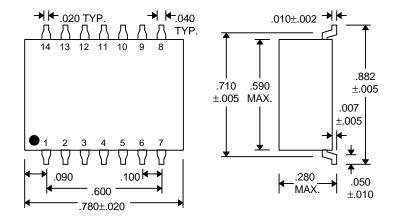
(0C to 70C, 4.75V to 5.25V)

PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
High Level Output Voltage	V_{OH}	3.98	4.4		V	$V_{DD} = 5.0, I_{OH} = MAX$
						$V_{IH} = MIN, V_{IL} = MAX$
Low Level Output Voltage	V_{OL}		0.15	0.26	V	$V_{DD} = 5.0, I_{OL} = MAX$
						$V_{IH} = MIN, V_{IL} = MAX$
High Level Output Current	I _{OH}			-4.0	mΑ	
Low Level Output Current	I _{OL}			4.0	mA	
High Level Input Voltage	V_{IH}	3.15			V	
Low Level Input Voltage	V_{IL}			1.35	V	
Input Current	I _{IH}			0.10	μΑ	$V_{DD} = 5.0$

PACKAGE DIMENSIONS



SMD99C-xx (Commercial)



SMD99C-xxMC2 (Military)

DELAY LINE AUTOMATED TESTING

TEST CONDITIONS

INPUT: OUTPUT:

Ambient Temperature: $25^{\circ}\text{C} \pm 3^{\circ}\text{C}$ **Load:** 1 FAST-TTL Gate

Supply Voltage (VDD): $5.0V \pm 0.1V$ C_{load}: $5pf \pm 10\%$

Input Pulse: High = $5.0V \pm 0.1V$ Threshold: 2.5V (Rising & Falling) Low = $0.0V \pm 0.1V$

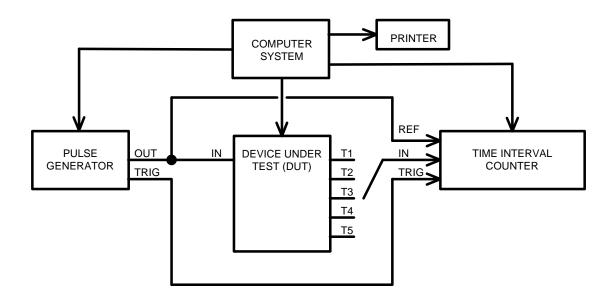
Source Impedance: 50Ω Max.

Rise/Fall Time: 5.0 ns Max. (measured

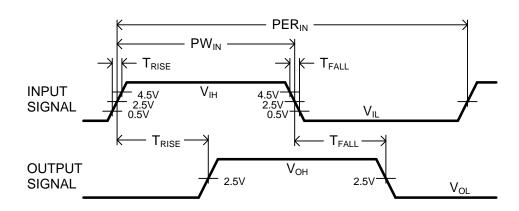
between 0.5V and 4.5V)

Pulse Width: $PW_{IN} = 1.5 \times Total Delay$ Period: $PER_{IN} = 10 \times Total Delay$

NOTE: The above conditions are for test only and do not in any way restrict the operation of the device.



Test Setup



Timing Diagram For Testing